

APPENDIX 3: Photographs of test setup

Conducted Emission
Slot in

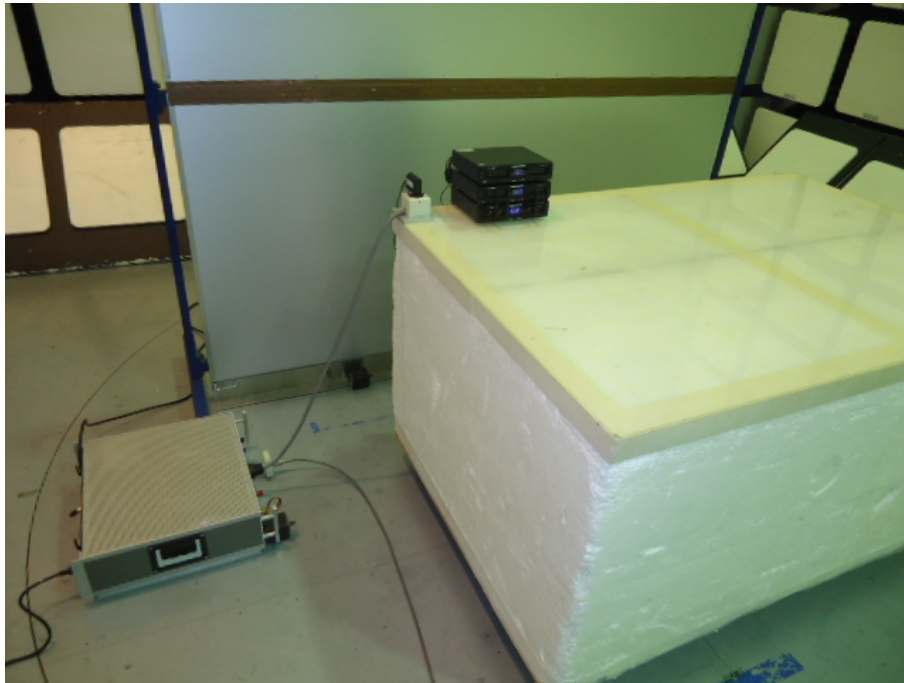


Photo 1

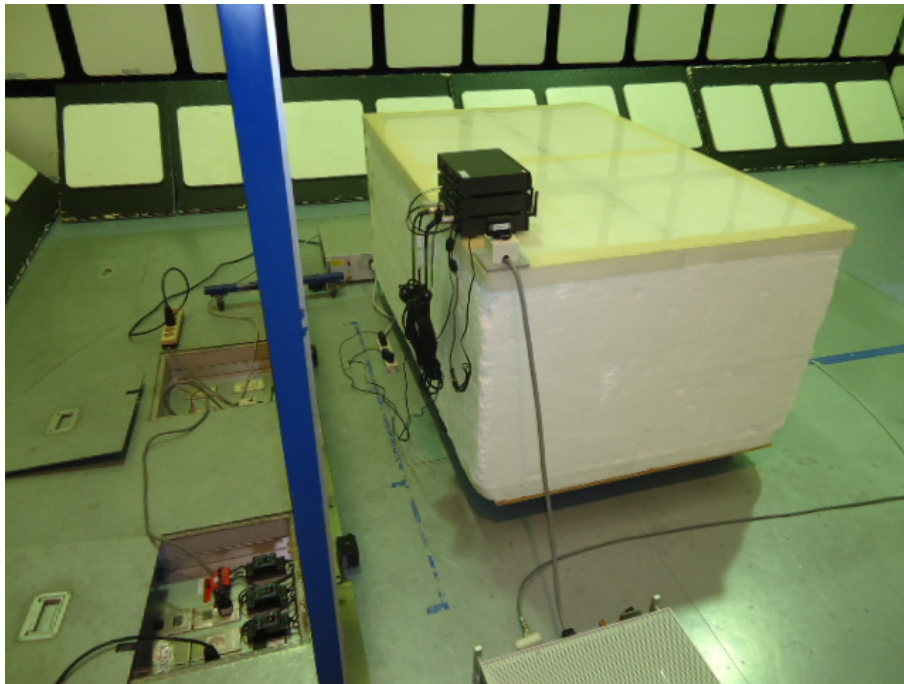


Photo 2

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Conducted Emission
External connect

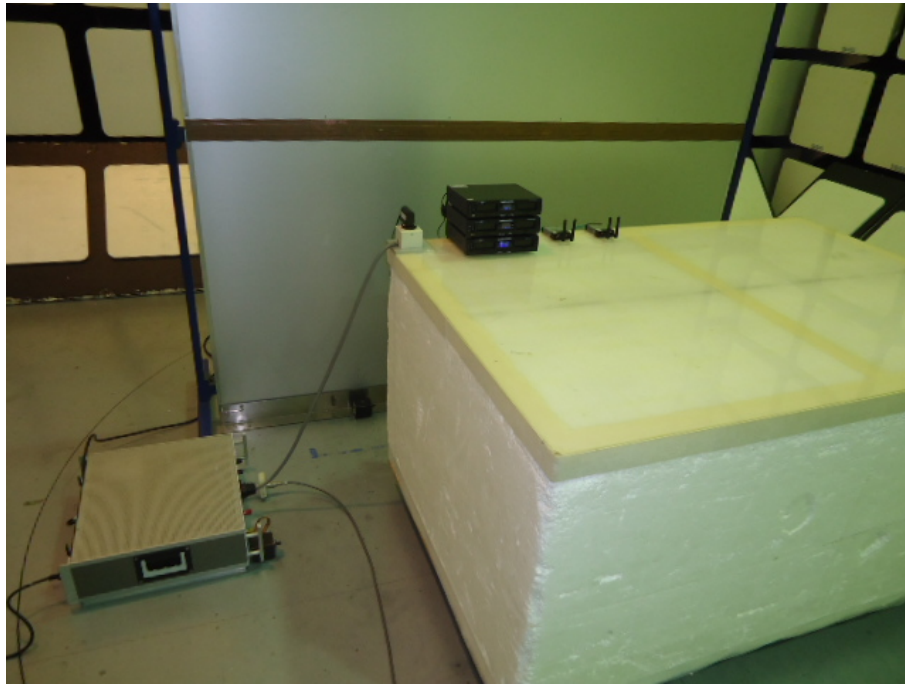


Photo 1

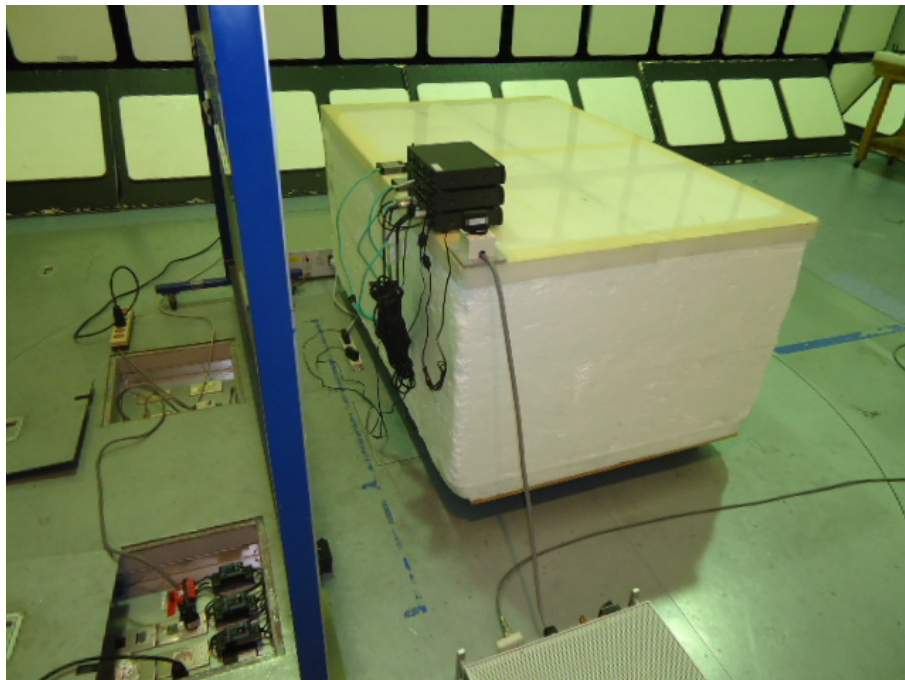


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Radiated Spurious Emission
Slot in (Below 1GHz)

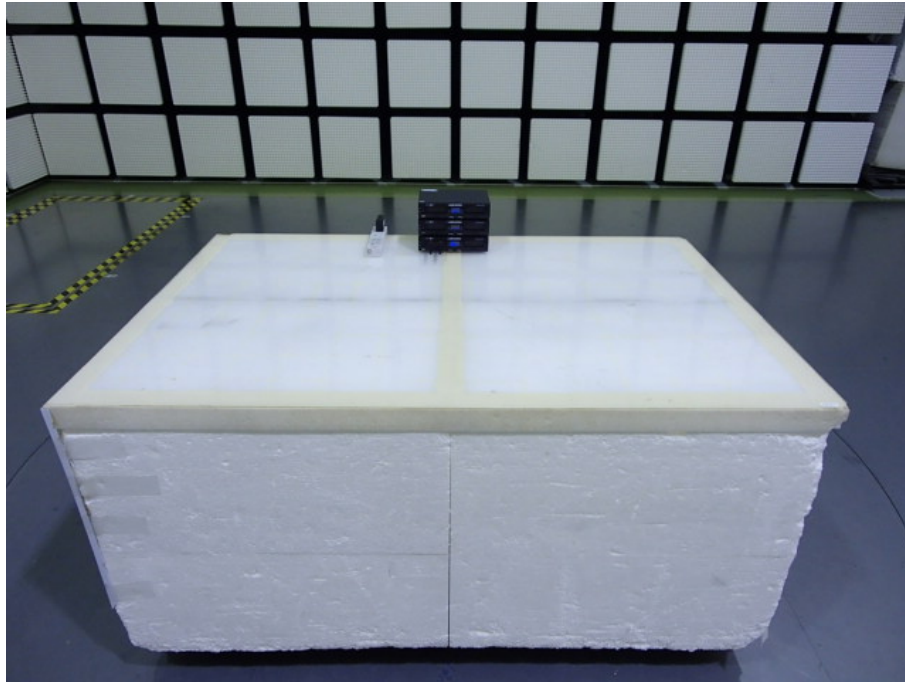


Photo 1

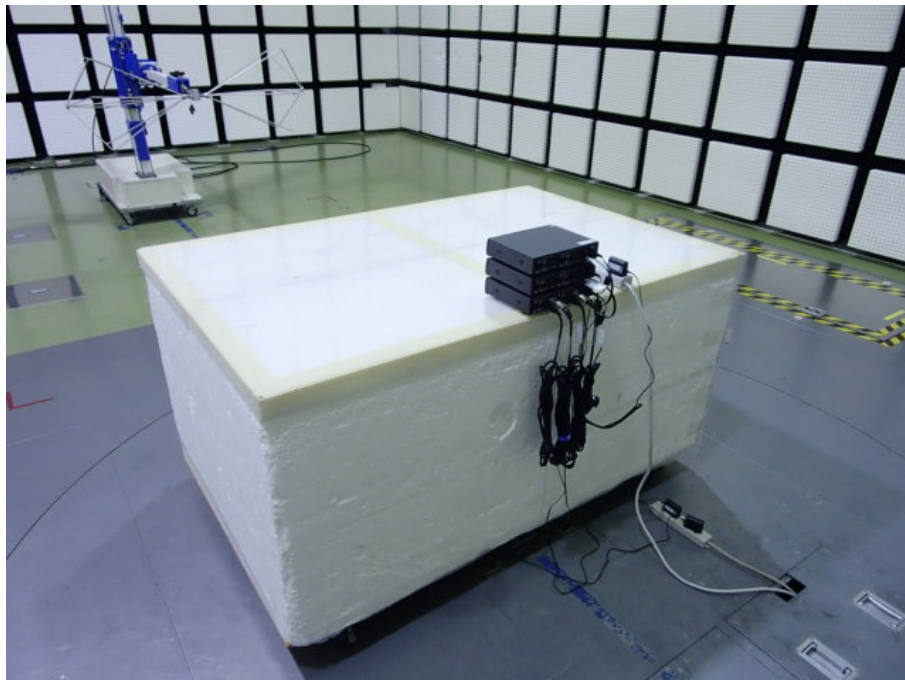


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Radiated Spurious Emission
External connect (Below 1GHz)

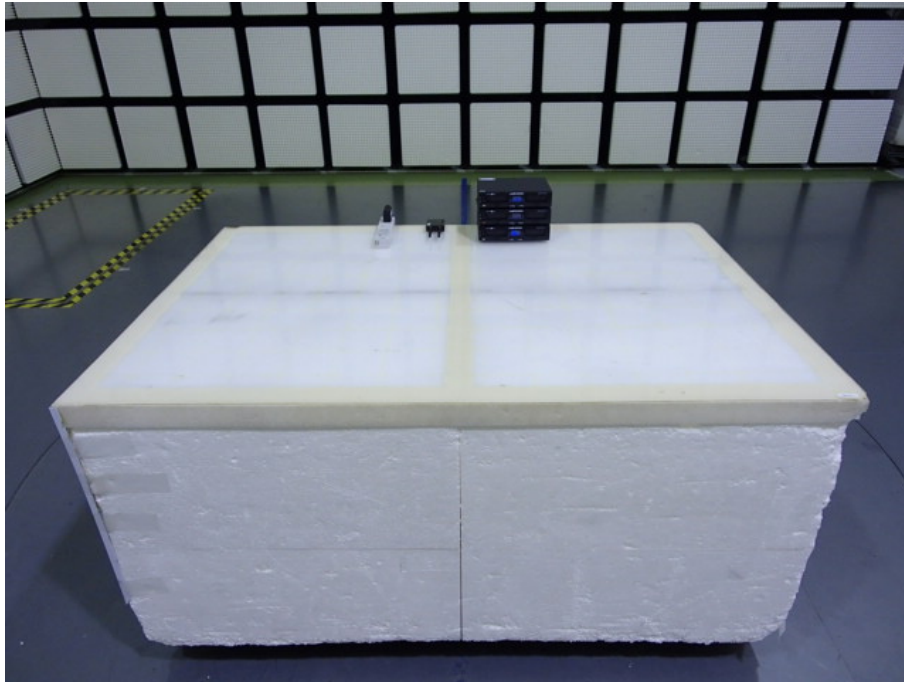


Photo 1

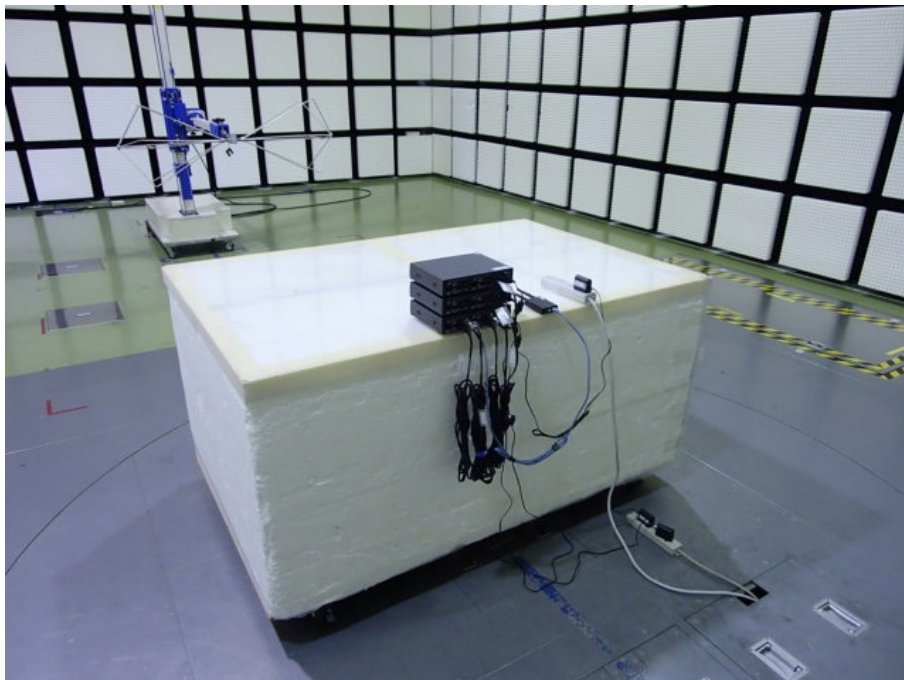


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Radiated Spurious Emission
(Above 1GHz)

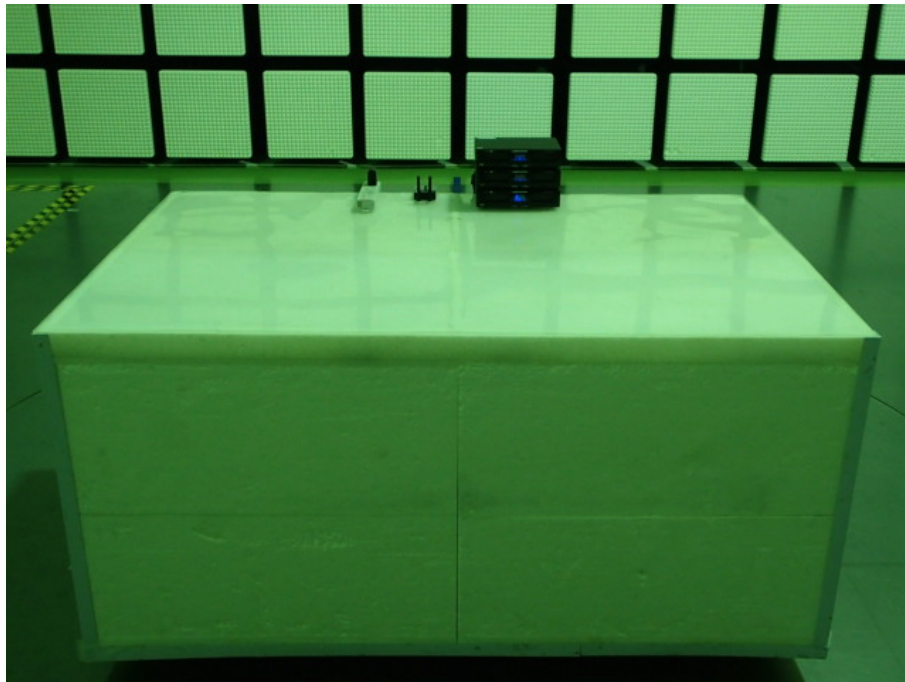


Photo 1

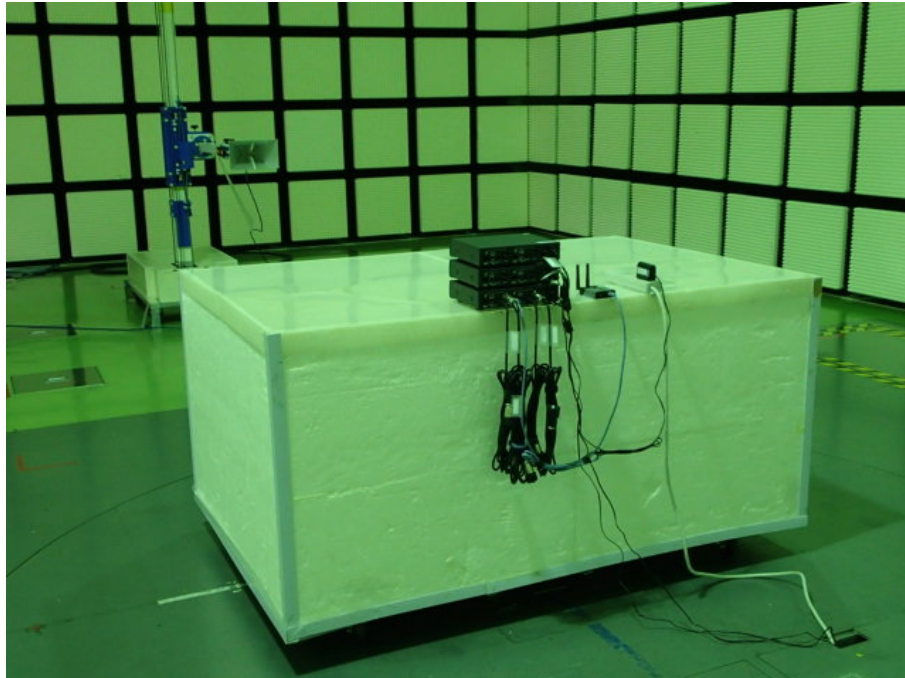


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Worst Case Position

30-300MHz (External: Horizontal: X-1-axis / Vertical: X-1-axis)

300-1000MHz (Slot in: Horizontal: X-axis / Vertical: X-axis)

Above 1GHz (External: Horizontal: Z-2-axis / Vertical: X-2-axis)

X-1-axis



Y-1-axis



X-2-axis



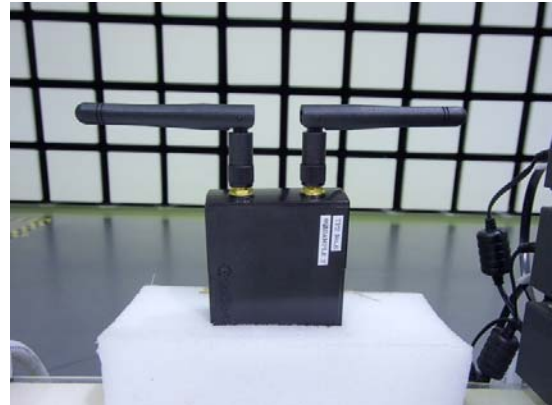
Y-2-axis



X-3-axis



Y-3-axis



Worst Case Position

Z-1-axis



X-axis



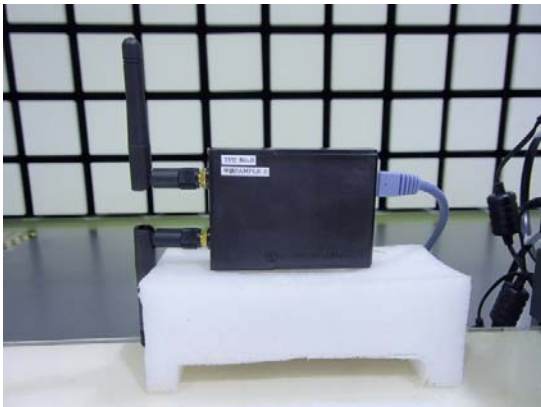
Z-2-axis



Y-axis



Z-3-axis



Z-axis



End of Report

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